ABSTRACT

Measurement of the dielectric properties of a material is required to obtain the basic

data of the dielectric properties of the material. Data from these measurements can be

utilized as reference data for the application of further dielectric properties such as data or

values of channel impedance, reflection and distortion. So the material can be further

investigated and can be determined if the material is better used as an antenna, reflector, or

adsorber, or how the material can react in certain circumstances.

In addition, we will be able to find out permittivity values that exist in a material.

Therefore, this study performs permittivity measurements using microstrip-based

transmission line method, with the help of obstacle that must be placed at different

positions above the microstrip channel for measurement. This method alone can minimize

the effects of non reproducibility connectors and impedance mismatch problems

commonly emerging in transmission line methods.

Measurements made using this method use a frequency of 2,45 GHz where the

frequency is the frequency of health standards licensed by Industrial, Scientific, and

Medical, which uses the CST application as a measurement simulator. The result of direct

measurement and measurement result using CST simulator it was found that the

permittivity value of Fr-4 dielectric material was 5,764 for simulation, 5,814 for VNA

measurement, Aramid was 3,442 for simulation, 3,353 for VNA measurement, Cotton was

2,892 for simulation, 2,822 for VNA and Polyster measurement was 2,39 for simulation,

2.39 for direct measurement.

Keyword: Permittivity, microstrip transmission line, CST

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